Dynamic Characteristics

Dynamic Chai		VRF157FL(MP)				
Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
C _{ISS}	Input Capacitance	V _{GS} = 0V		1580		
C _{oss}	Output Capacitance	V _{DS} = 50V		810		pF
C _{rss}	Reverse Transfer Capacitance	f = 1MHz		65		

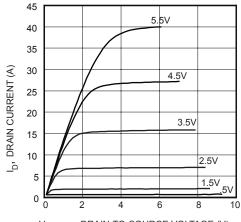
Functional Characteristics

Symbol	Parameter	Min	Тур	Max	Unit
G _{PS}	f = 30MHz, V _{DD} = 50V, I _{DQ} = 800mA, P _{out} = 600W	17	21		dB
$\eta_{\scriptscriptstyle D}$	$f = 30MHz, V_{DD} = 50V, I_{DQ} = 800mA, P_{out} = 600W_{PEP}$		45		%
IMD _(d3)	f1 = 30MHz, f2 = 30.001MHz, V_{DD} = 50V, I_{DQ} = 800mA, P_{out} = 600W _{PEP} ¹		-25		dBc
Ψ	f = 30MHz, V_{DD} = 50V, I_{DQ} = 800mA, P_{out} = 600W CW 70:1 VSWR - All Phase Angles, 0.2mSec X 20% Duty Factor	No Degradation in Output Power		Power	

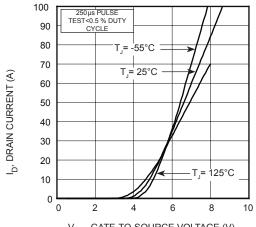
^{1.} To MIL-STD-1311 Version A, test method 2204B, Two Tone, Reference Each Tone

 ${\bf Microsemi\ reserves\ the\ right\ to\ change,\ without\ notice,\ the\ specifications\ and\ information\ contained\ herein.}$

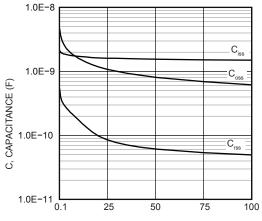
Typical Performance Curves



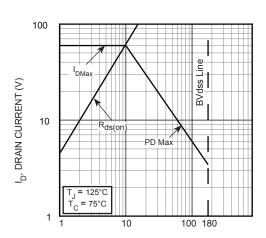
V_{DS(ON)}, DRAIN-TO-SOURCE VOLTAGE (V) FIGURE 1, Output Characteristics



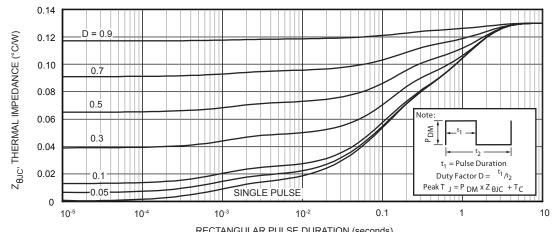
V_{GS}, GATE-TO-SOURCE VOLTAGE (V) FIGURE 2, Transfer Characteristics



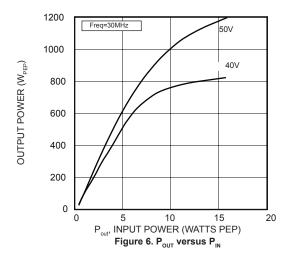
 V_{DS} , DRAIN-TO-SOURCE VOLTAGE (V) FIGURE 3, Capacitance vs Drain-to-Source Voltage

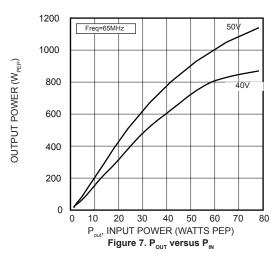


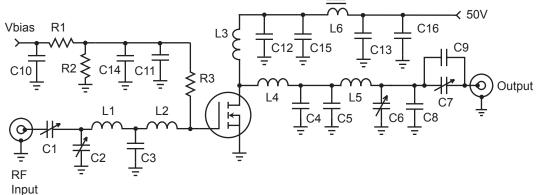
 $V_{DS}^{}$, DRAIN-TO-SOURCE VOLTAGE (V) FIGURE 4, Forward Safe Operating Area



RECTANGULAR PULSE DURATION (seconds)
Figure 5. Maximum Effective Transient Thermal Impedance Junction-to-Case vs Pulse Duration

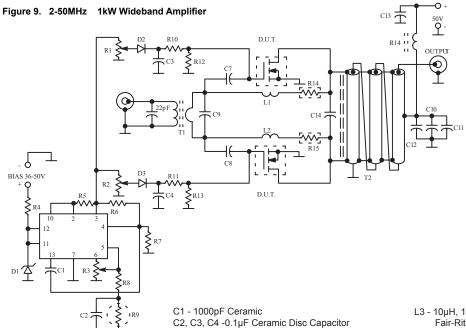






C1, C2, C6, C7 ARCO 465 mica trimmer C3 1800pF ATC700B ceramic C4 680pF metal clad 500V mica C5 390pF metal clad 500V mica C8 100pF ATC 700E ceramic C9 120pF ATC 700E ceramic C10 - C13 .01uF 100V ceramic SMT C14 - C16 .1uF 100V ceramic SMT

L1 110nH 4t #22 0.312"d .30"l L2 29nH 2t #22 .188" dia .10" I L3 0.3uH - 6t #16 enam. .5" dia. L4 22nH - 1t #16 enam. .375" dia. L5 117nH - 3t #16 enam. .5" dia. .3"I L6 1t #16 on 2x 267300081 .5" bead R1-R2 1kΩ 1/4W R3 10Ω 1/4W



C5 - 0.01µF Ceramic Chip Capacitor

C6, C12 - 0.1µF Ceramic Chip Capacitor

C7, C8 - Two 2200 pF Ceramic Chip Capacitors in Parallel

C9 - 820pF Ceramic Chip Capacitor

C10, C1 1 - 1000pF Ceramic Chip Capacitor

C13 - 0.47µF Ceramic Chip Capacitor or Two Smaller Values in Parallel

C14 - Unencapsulated Mica, 500V Two 1000pF Units in Series, Mounted Under T2

D1 - IN5357A or Equivalent

D2, D3 - IN4148 or Equivalent

C1 - MC1723 (723) Voltage Regulator

L1, L2 - 15 ηH Connecting Wires to R14 and R15, 2.5cm Each #20 AWG

L3 - 10µH, 10 Turns #12 AWG Enameled Wire on Fair-Rite Products Corp. Ferrite Toroid #5961000401 or Equivalent

R1, R2 - 1.0K Single Turn Trimpots

R3 - 10K Single Turn Trimpot

R4 - 470 Ohms, 2.0 Watts

R5 - 10 Ohms

R6, R12, R13 - 2.0K Ohms

R7 - 10K Ohms

R8 - Exact Value Depends on Thermistor R9 used (Typically 5.0 - 10K)

- Thermistor, Keystone RL1009-5820-97-D1 or Equivalent

R10, R11 - 100 Ohms, 1.0W Carbon

R14, R15 - EMC Technology Model 5308 or KDI Pyrofilm PPR 970-150-3 Power Resistors, 25 Ohms

T1, T2 - 9:1 and 1:9 Impedance Ratio RF Transformers

Adding MP at the end of P/N specifies a matched pair where $V_{GS(TH)}$ is matched between the two parts. V_{TH} values are marked on the devices per the following table.

Code	Vth Range	Code 2	Vth Range	
А	2.900 - 2.975	М	3.650 - 3.725	
В	2.975 - 3.050	N	3.725 - 3.800	
С	3.050 - 3.125	Р	3.800 - 3.875	
D	3.125 - 3.200	R	3.875 - 3.950	
E	3.200 - 3.275	S	3.950 - 4.025	
F	3.275 - 3.350	Т	4.025 - 4.100	
G	3.350 - 3.425	W	4.100 - 4.175	
Н	3.425 - 3.500	Х	4.175 - 4.250	
J	3.500 - 3.575	Υ	4.250 - 4.325	
K	3.575 - 3.650	Z	4.325 - 4.400	

 $V_{\scriptscriptstyle TH}$ values are based on Microsemi measurements at datasheet conditions with an accuracy of 1.0%.

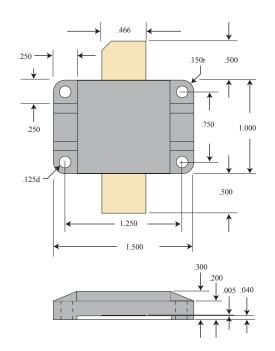
Thermal Considerations and Package Mounting:

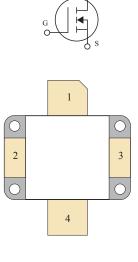
The rated 1350W power dissipation is only available when the package mounting surface is at 25°C and the junction temperature is 200°C. The thermal resistance between junctions and case mounting surface is 0.13°C/W. When installed, an additional thermal impedance of 0.09°C/W between the package base and the mounting surface is smooth and flat. Thermal joint compound must be used to reduce the effects of small surface irregularities. The heatsink should incorporate a copper heat spreader to obtain best results.

The lid maintains the required mounting pressure while allowing for thermal expansion of both the device and the heat sink. Four 4-40 (M3) screws provide the minimum 125 lb. required mounting force. T=4-6 in-lb. Please refer to App Note 1810 "Mounting Instructions for Flangeless Packages."

HAZARDOUS MATERIAL WARNING

The ceramic portion of the device between leads and mounting flange is beryllium oxide. Beryllium oxide dust is highly toxic when inhaled. Care must be taken during handling and mounting to avoid damage to this area. These devices must never be thrown away with general industrial or domestic waste. BeO substrate weight: 1.934g. Percentage of total module weight which is BeO: 20%.





PIN 1 - DRAIN PIN 2 - SOURCE

PIN 2 - SOURCE PIN 3 - SOURCE

PIN 4 - GATE



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